

# OptiMOS<sup>™</sup>2 Small-Signal-Transistor

## **Features**

- N-channel
- Enhancement mode
- Logic level (4.5V rated)
- Avalanche rated
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant
- Halogen-free according to IEC61249-2-21

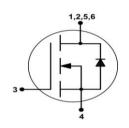




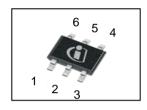


# **Product Summary**

$V_{ m DS}$		30	V
$R_{\mathrm{DS(on),max}}$	V <sub>GS</sub> =10 V	160	mΩ
	V <sub>GS</sub> =4.5 V	280	
I <sub>D</sub>		1.4	Α



## PG-SOT363



Туре	Package	Tape and Reel Information	Marking	Lead Free	Packing
BSD316SN	PG-SOT363	H6327: 3000 pcs/ reel	X7s	Yes	Non dry

# **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I <sub>D</sub>	T <sub>A</sub> =25 °C	1.4	А
		T <sub>A</sub> =70 °C	1.1	
Pulsed drain current	I <sub>D,pulse</sub>	T <sub>A</sub> =25 °C	5.6	
Avalanche energy, single pulse	E <sub>AS</sub>	$I_{\rm D} = 1.4  {\rm A},  R_{\rm GS} = 25  {\rm \Omega}$	3.7	mJ
Reverse diode d $v$ /d $t$	dv/dt	I <sub>D</sub> =1.4 A, V <sub>DS</sub> =16 V, d <i>i</i> /d <i>t</i> =200 A/μs, T <sub>j,max</sub> =150 °C	6	kV/µs
Gate source voltage	$V_{GS}$		±20	V
Power dissipation	$P_{\text{tot}}$	T <sub>A</sub> =25 °C	0.5	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
ESD Class		JESD22-A114 -HBM	0 (<250V)	
Soldering Temperature			260 °C	
IEC climatic category; DIN IEC 68-1			55/150/56	



Parameter	Symbol Conditions	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - ambient	$R_{thJA}$	minimal footprint <sup>1)</sup>	-	-	250	K/W

# **Electrical characteristics,** at $T_j$ =25 °C, unless otherwise specified

## Static characteristics

Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0 V, I <sub>D</sub> =250 μA	30	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}$ , $I_{\rm D} = 3.7~\mu{\rm A}$	1.2	1.6	2.0	
Drain-source leakage current	I <sub>DSS</sub>	$V_{\rm DS} = 30 \text{ V}, V_{\rm GS} = 0 \text{ V}, $ $T_{\rm j} = 25 \text{ °C}$	1	1	1	μΑ
		V <sub>DS</sub> =30 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =150 °C	-	1	100	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	-	-	100	nA
Drain-source on-state resistance	$R_{\mathrm{DS(on)}}$	V <sub>GS</sub> =4.5 V, I <sub>D</sub> =1.1 A	1	192	280	mΩ
		V <sub>GS</sub> =10 V, I <sub>D</sub> =1.4 A	1	120	160	
Transconductance	$g_{fs}$	$ V_{\rm DS}  > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 1.1 \text{ A}$	-	2.3	1	S

 $<sup>^{1)}</sup>$  Performed on  $40 mm^2$  FR4 PCB. The traces are 1mm wide,  $70 \mu m$  thick and 20mm long; they are present on both sides of the PCB.



Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	71	94	pF
Output capacitance	Coss	V <sub>GS</sub> =0 V, V <sub>DS</sub> =15 V, f=1 MHz	-	26	35	
Reverse transfer capacitance	C <sub>rss</sub>		-	5	7	
Turn-on delay time	$t_{d(on)}$		-	3.4	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =15 V, V <sub>GS</sub> =10 V,	-	2.3	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =1.4 A, $R_{\rm G,ext}$ =6 $\Omega$	-	5.8	-	
Fall time	$t_{\mathrm{f}}$	]	-	1.0	-	
Gate Charge Characteristics						•
Gate to source charge	Q <sub>gs</sub>	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =1.4 A, $V_{\rm GS}$ =0 to 5 V	-	0.3	-	nC
Gate to drain charge	$Q_{gd}$		-	0.2	-	
Gate charge total	Qg		-	0.6	-	
Gate plateau voltage	$V_{\rm plateau}$		-	3.4	-	V
Reverse Diode						
Diode continous forward current	Is	T _25 °C	-	-	0.5	А
Diode pulse current	I <sub>S,pulse</sub>	− T <sub>A</sub> =25 °C	-	-	5.6	
Diode forward voltage	$V_{\mathrm{SD}}$	V <sub>GS</sub> =0 V, I <sub>F</sub> =1.4 A, T <sub>j</sub> =25 °C	-	0.8	1.1	V
Reverse recovery time	t <sub>rr</sub>	$V_{R}$ =15 V, $I_{F}$ =1.4 A, $di_{F}/dt$ =100 A/ $\mu$ s	-	9.1	-	ns
Reverse recovery charge	Q <sub>rr</sub>		-	2.6	-	nC

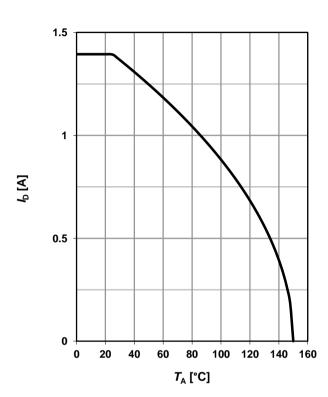


## 1 Power dissipation

# $P_{\text{tot}} = f(T_A)$

# 0.375 0.375 0.125 0.125 0.125 0.120 160 T<sub>A</sub> [°C]

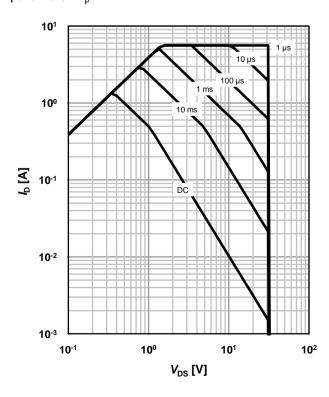
## 2 Drain current



# 3 Safe operating area

 $I_D=f(V_{DS}); T_A=25 \text{ °C}; D=0$ 

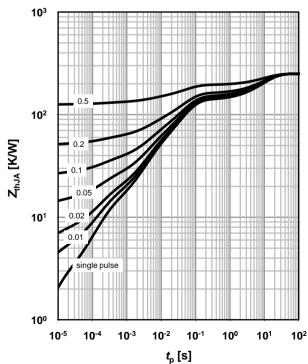
parameter:  $t_p$ 



## 4 Max. transient thermal impedance

 $Z_{\text{thJA}} = f(t_p)$ 

parameter:  $D=t_p/T$ 

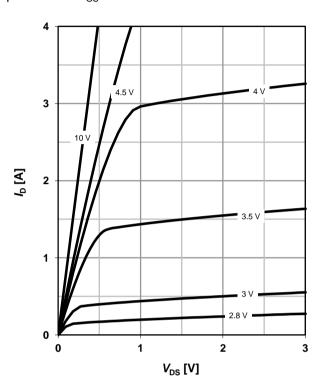




# 5 Typ. output characteristics

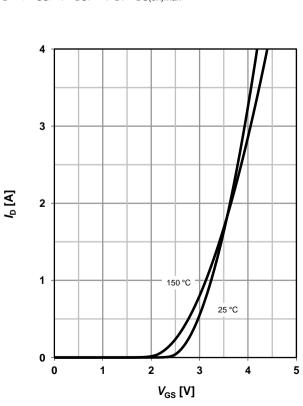
 $I_D=f(V_{DS}); T_j=25 °C$ 

parameter:  $V_{\rm GS}$ 



# 7 Typ. transfer characteristics

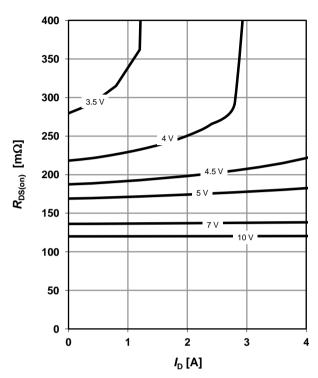
 $I_{D}=f(V_{GS}); |V_{DS}|>2|I_{D}|R_{DS(on)max}$ 



## 6 Typ. drain-source on resistance

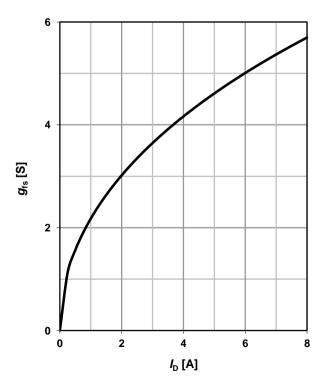
 $R_{DS(on)}=f(I_D); T_j=25 \text{ °C}$ 

parameter: V<sub>GS</sub>



# 8 Typ. forward transconductance

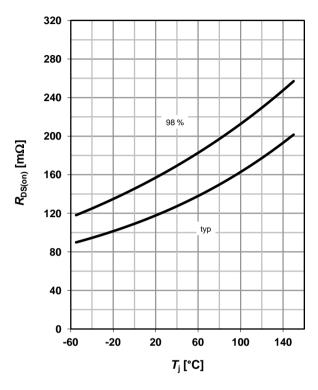
 $g_{fs}$ =f( $I_D$ );  $T_j$ =25 °C





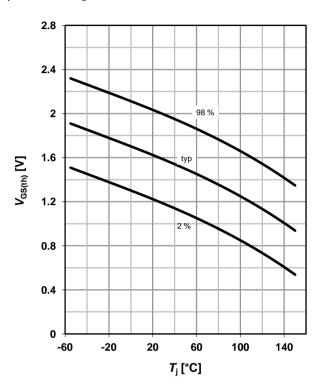
## 9 Drain-source on-state resistance

 $R_{DS(on)} = f(T_i); I_D = 1.4 A; V_{GS} = 10 V$ 



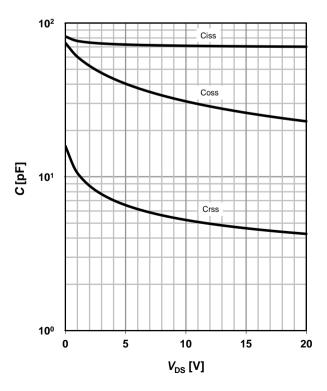
# 10 Typ. gate threshold voltage

 $V_{\text{GS(th)}}$ =f( $T_{\text{j}}$ );  $V_{\text{DS}}$ = $V_{\text{GS}}$ ;  $I_{\text{D}}$ =3.7  $\mu$ A parameter:  $I_{\text{D}}$ 



# 11 Typ. capacitances

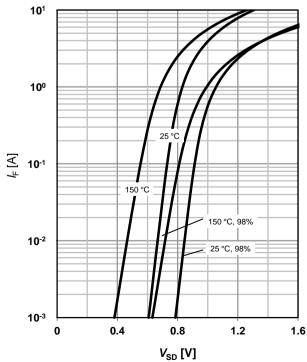
 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz; T_i=25$ °C



## 12 Forward characteristics of reverse diode

 $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$ 

parameter: T<sub>i</sub>

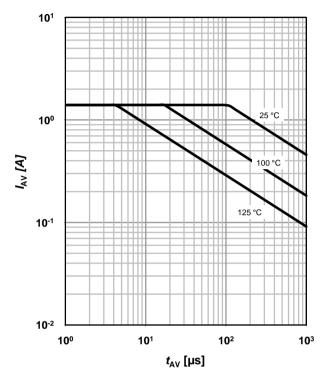




## 13 Avalanche characteristics

 $I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$ 

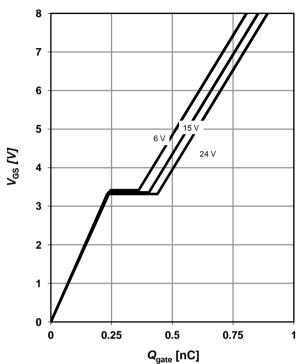
parameter:  $T_{j(start)}$ 



## 14 Typ. gate charge

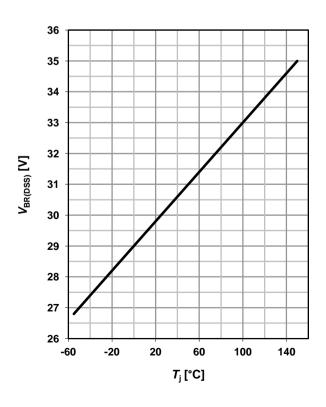
 $V_{GS}$ =f(Q<sub>gate</sub>);  $I_D$ =1.4 A pulsed

parameter:  $V_{\rm DD}$ 

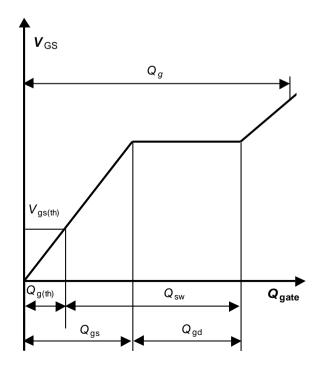


## 15 Drain-source breakdown voltage

 $V_{BR(DSS)}=f(T_j); I_D=250 \mu A$ 



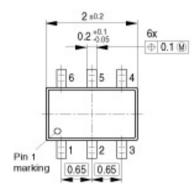
## 16 Gate charge waveforms

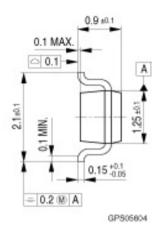




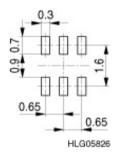
## **SOT363**

# Package Outline:

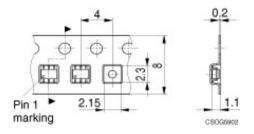




# Reflow soldering:



# Packing:





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